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- Inputs Are TTL Compatible
- **EPIC™** (Enhanced-Performance Implanted CMOS) 1-µm Process
- **Package Options Include Plastic** Small-Outline (DW), Shrink Small-Outline (DB), Thin Shrink Small-Outline (PW), and Flat (W) Packages, Ceramic Chip Carriers (FK), and Plastic (N) and Ceramic (J) DIPs

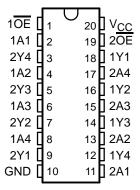
description

These octal buffers/drivers are designed specifically to improve the performance and density of 3-state memory address drivers, clock drivers. and bus-oriented receivers transmitters.

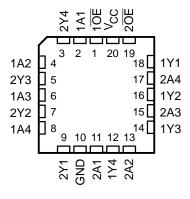
The 'ACT244 are organized as two 4-bit buffers/drivers with separate output-enable (\overline{OE}) inputs. When \overline{OE} is low, the device passes noninverted data from the A inputs to the Y outputs. When OE is high, the outputs are in the high-impedance state.

The SN54ACT244 is characterized for operation over the full military temperature range of -55°C to 125°C. The SN74ACT244 is characterized for operation from -40°C to 85°C.

SN54ACT244 . . . J OR W PACKAGE SN74ACT244 . . . DB, DW, N, OR PW PACKAGE (TOP VIEW)



SN54ACT244 . . . FK PACKAGE (TOP VIEW)



FUNCTION TABLE (each buffer)

INP	JTS	OUTPUT
OE	Α	Υ
L	Н	Н
L	L	L
Н	Χ	Z

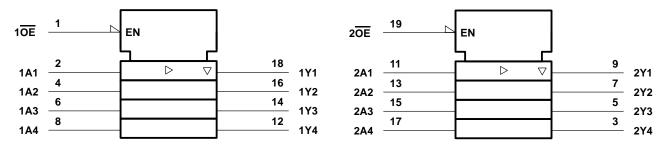


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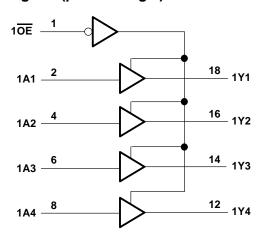


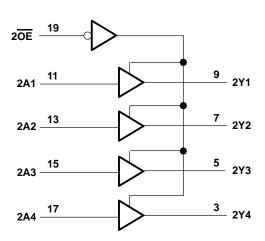
logic symbol†



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagram (positive logic)





absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage range, V _{CC}	0.5 V to 7 V
Input voltage range, V _I (see Note 1)	0.5 V to V _{CC} + 0.5 V
Output voltage range, V _O (see Note 1)	0.5 V to V _{CC} + 0.5 V
Input clamp current, I _{IK} (V _I < 0 or V _I > V _{CC})	±20 mA
Output clamp current, I_{OK} ($V_O < 0$ or $V_O > V_{CC}$)	±20 mA
Continuous output current, I_O ($V_O = 0$ to V_{CC})	±50 mA
Continuous current through V _{CC} or GND	±200 mA
Maximum power dissipation at $T_A = 55^{\circ}C$ (in still air) (see Note 2):	: DB package 0.6 W
	DW package1.6 W
	N package 1.3 W
	PW package 0.7 W
Storage temperature range, T _{stg}	–65°C to 150°C

[‡] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.



NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

^{2.} The maximum package power dissipation is calculated using a junction temperature of 150°C and a board trace length of 750 mils, except for the N package, which has a trace length of zero.

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recommended operating conditions (see Note 3)

		SN54ACT244		SN74A	UNIT	
		MIN	MAX	MIN	MAX	UNIT
Vcc	Supply voltage	4.5	5.5	4.5	5.5	V
VIH	High-level input voltage	2		2		V
VIL	Low-level input voltage		0.8		0.8	V
٧ _I	Input voltage	0	VCC	0	VCC	V
٧o	Output voltage	0	Vcc	0	VCC	٧
ІОН	High-level output current		-24		-24	mA
loL	Low-level output current		24		24	mA
Δt/Δν	Input transition rise or fall rate	0	8	0	8	ns/V
T _A	Operating free-air temperature	-55	125	-40	85	°C

NOTE 3: Unused inputs must be held high or low to prevent them from floating.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V	T _A = 25°C			SN54ACT244		SN74ACT244		UNIT	
PARAMETER		VCC	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT	
	- FO. A	4.5 V	4.4	4.49		4.4		4.4			
	I _{OH} = -50 μA		5.4	5.49		5.4		5.4			
l Va	I _{OL} = -24 mA	4.5 V	3.86			3.7		3.76		\ _\	
VOH		5.5 V	4.86			4.7		4.76		V	
	$I_{OH} = -50 \text{ mA}^{\dagger}$	5.5 V				3.85					
	I _{OH} = -75 mA [†]	5.5 V						3.85			
	I _{OL} = 50 μA	4.5 V		0.001	0.1		0.1		0.1	V	
		5.5 V		0.001	0.1		0.1		0.1		
\/a.	I _{OL} = 24 mA	4.5 V			0.36		0.5		0.44		
VOL		5.5 V			0.36		0.5		0.44		
	I _{OL} = 50 mA [†]	5.5 V					1.65				
	I _{OL} = 75 mA [†]	5.5 V							1.65]	
loz	$V_O = V_{CC}$ or GND	5.5 V			±0.25		±5		±2.5	μΑ	
ΙΙ	V _I = V _{CC} or GND	5.5 V			±0.1		±1		±1	μА	
lcc	$V_I = V_{CC}$ or GND, $I_O = 0$	5.5 V			4		80		40	μА	
∆lcc [‡]	One input at 3.4 V, Other inputs at GND or V _{CC}	5.5 V		0.6			1.6		1.5	mA	
Ci	V _I = V _{CC} or GND	5 V		2.5						pF	
Co	V _I = V _{CC} or GND	5 V		8						pF	

[†] Not more than one output should be tested at a time, and the duration of the test should not exceed 2 ms.



[‡] This is the increase in supply current for each input that is at one of the specified TTL voltage levels rather than 0 V or V_{CC}.

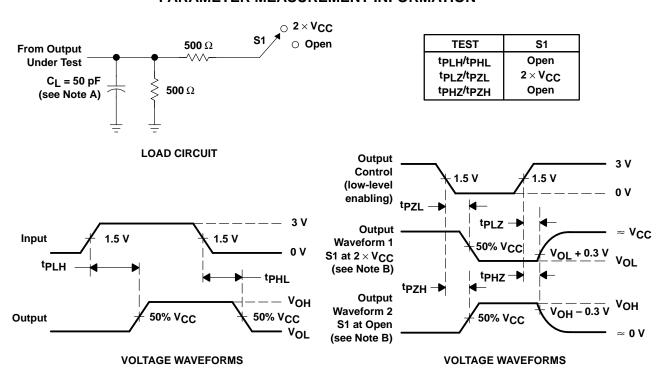
switching characteristics over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V (unless otherwise noted) (see Figure 1)

PARAMETER	FROM TO (OUTPUT	TO (OUTPUT)	T _A = 25°C			SN54ACT244		SN74ACT244		UNIT
TANAMETER			MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
^t PLH	А	Y	2	6.5	9	1	10	1.5	10	ns
^t PHL			2	7	9	1	10	1.5	10	
^t PZH	ŌĒ	Y	1.5	7	8.5	1	9.5	1	9.5	20
^t PZL			2	7	9.5	1	11	1.5	10.5	ns
^t PHZ	ŌĒ	V	2	8	9.5	1	11	1.5	10.5	50
t _{PLZ}		ī	2.5	7.5	10	1	11.5	2	10.5	ns

operating characteristics, V_{CC} = 5 V, T_A = 25°C

PARAMETER		TEST COM	TYP	UNIT	
C _{pd}	Power dissipation capacitance per buffer/driver	$C_L = 50 pF$,	f = 1 MHz	45	pF

PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, $Z_O = 50~\Omega$, $t_f \leq$ 2.5 ns, $t_f \leq$ 2.5 ns.
- D. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms



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